

FSU CAPS Overview and Updates

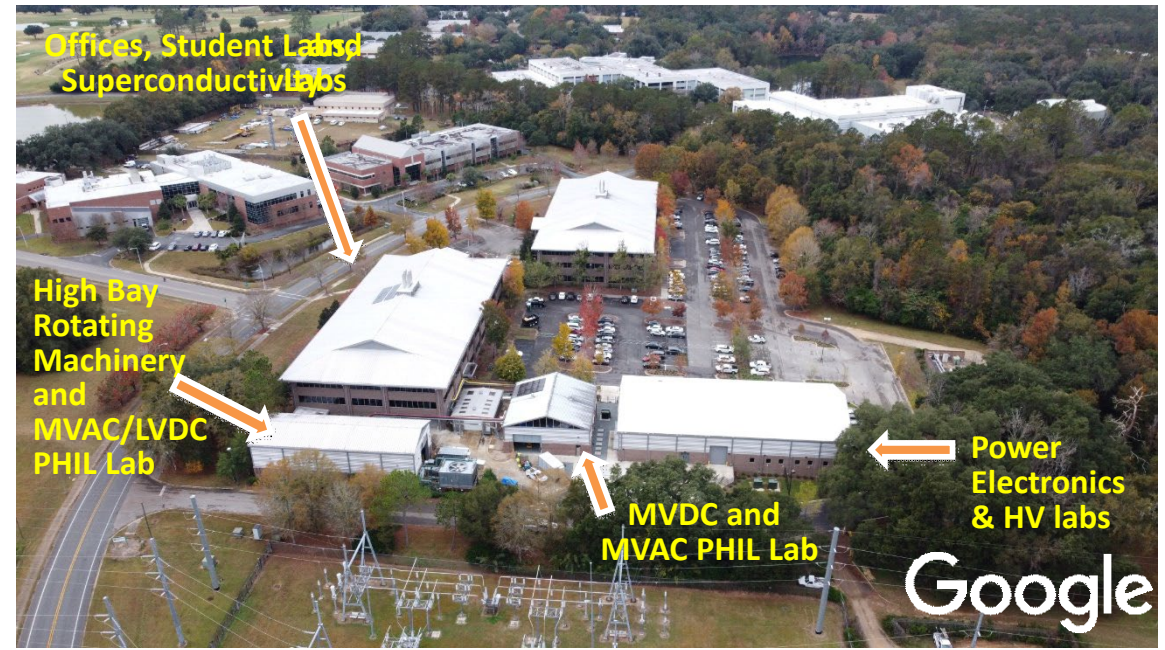
October 2024
schoder @ caps.fsu.edu



FSU Center for Advanced Power Systems



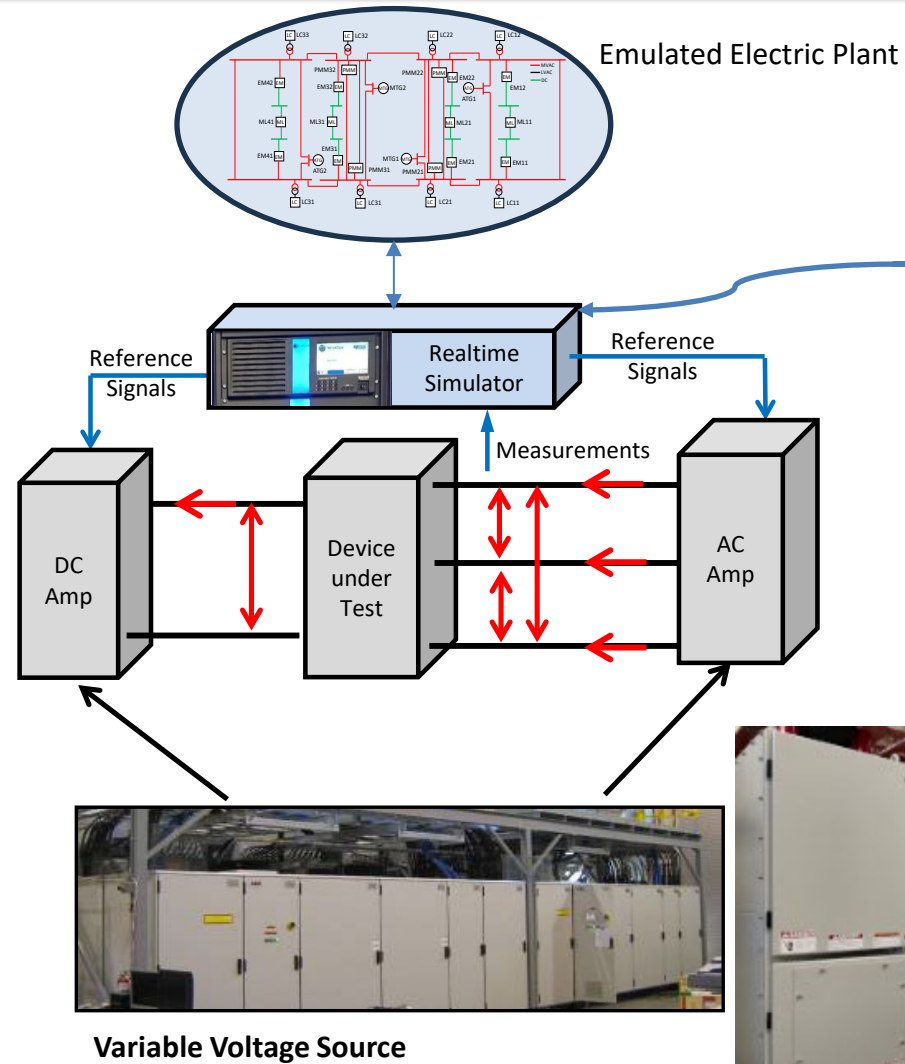
Collaborations with Academia and National Labs



Industry Collaborator and Sponsors

Create a Virtual yet Realistic Environment to Rapidly Test Equipment and Interfaces: PHIL

- Couple Device Under test (DUT) to a Real Time Computer Simulation using amplifiers and/or actuators (preserves natural coupling)
- Use of PHIL Simulation
 - Testing in Realistic Environment
 - Early integration testing
 - Flexibility to quickly change surrounding system and conditions to test equipment performance envelope
 - Validate System Specification & Interfaces
 - Testing with yet unrealized system
 - Test extreme conditions within controllable lab environment



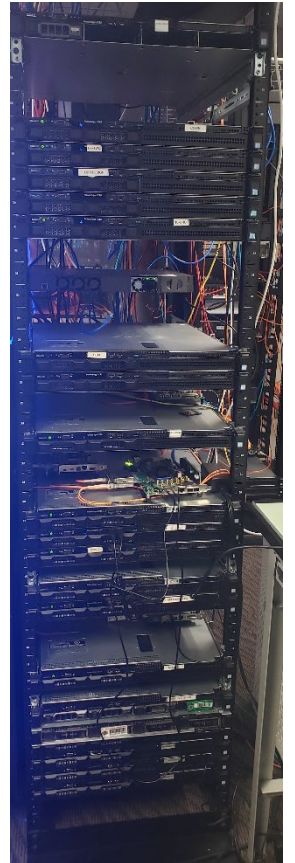
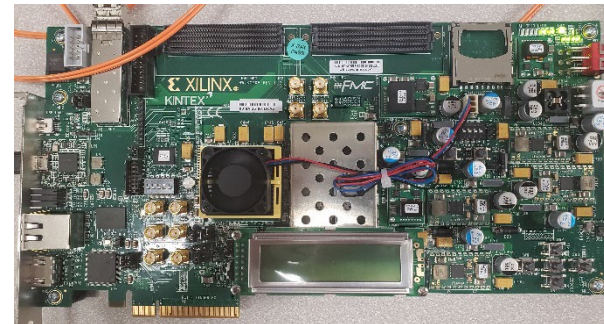
CAPS RT Simulators

- RTDS Novacore (9)
- SpeedGoat (2)
- Typhoon HIL (3)
- Opal-RT (2)

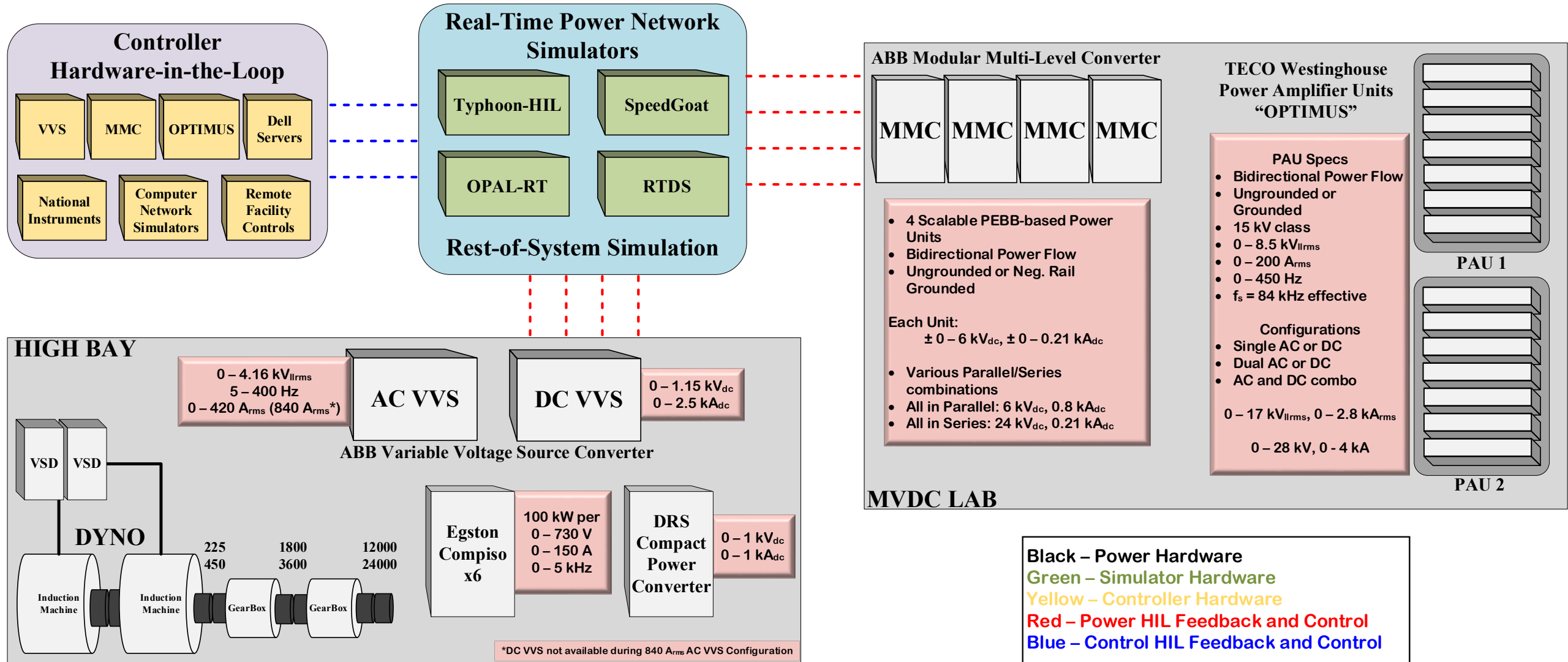
Co-Simulation

- Portion of model on real-time simulator (RTS) and [portion of model on co-simulation machines](#)
- Model on co-sim machine executes faster than real time – [clocked from RTS](#)
- Model on co-sim machine [can execute in native software package](#) (e.g. MATLAB/Simulink, nVe, compiled executable, etc.)
- Useful for
 - [Protected vendor models](#) that cannot be ported or re-compiled for RTS as target
 - Complicated [models that are difficult to manually port](#)
 - Models with subsystems [allowing larger time-step sizes](#) (e.g. generator set with prime mover, AVR/exciter, and synchronous machine)
 - Controls
- FPGAs used for [high-speed digital link](#) between co-sim machine and RTS

- RTDS 9x 10-NovaCors
- (35) x86-64 servers
- (30) Xilinx-based FPGA

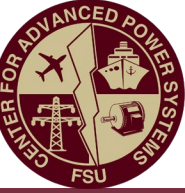


5 MW PHIL Facility Overview



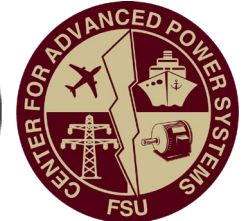
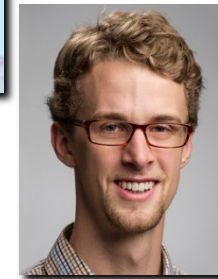


Recommended Practice for Hardware-in-the-Loop (HIL) Simulation Based Testing of Electric Power Apparatus and Controls – IEEE WG P2004



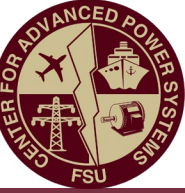
Michael “Mischa” Steurer pioneered HIL and initiated IEEE WG P2004.

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Enphase Energy, Fremont, CA, USA
- Sponsor: **PELS**, Co-sponsor: **IAS, IES**
- Collaboration: **PSRC WG CTF-33**; IEEE task force (TF) on “Real-Time Simulation of Power and Energy Systems”, chaired by Dr. Omar Faruque, under **IEEE WG 15.08.09** (within the General System Subcommittee of the IEEE PES T&D Committee)





Generator Testing – Constant Power



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Generator Testing Motivation

Improve (cost) efficiency of backup generation

- Re-rate and save on units required
- Hardware of interest: diesel generator (DG) with 13.8 kV, 60 Hz, 3.5 MVA

Testing DG with increased generation capacity at increased power factor

- 2.8 MW @ 0.8 p \rightarrow 3 MW @ 0.98 pf

Factory Acceptance Test (FAT) shows DG able to handle 0-100% block loads w/ load bank

- FAT with load banks not reflecting application load:
- Feasible for constant power loading?
 - First of its kind: generator + PHIL constant power load



Hardware components

- 1x Generator under test

Test infrastructure

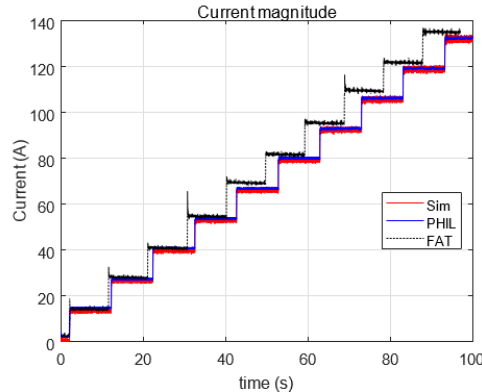
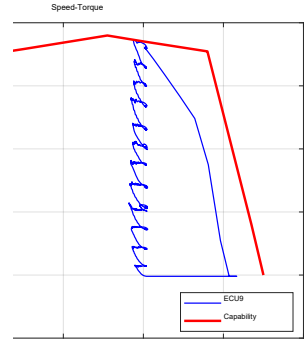
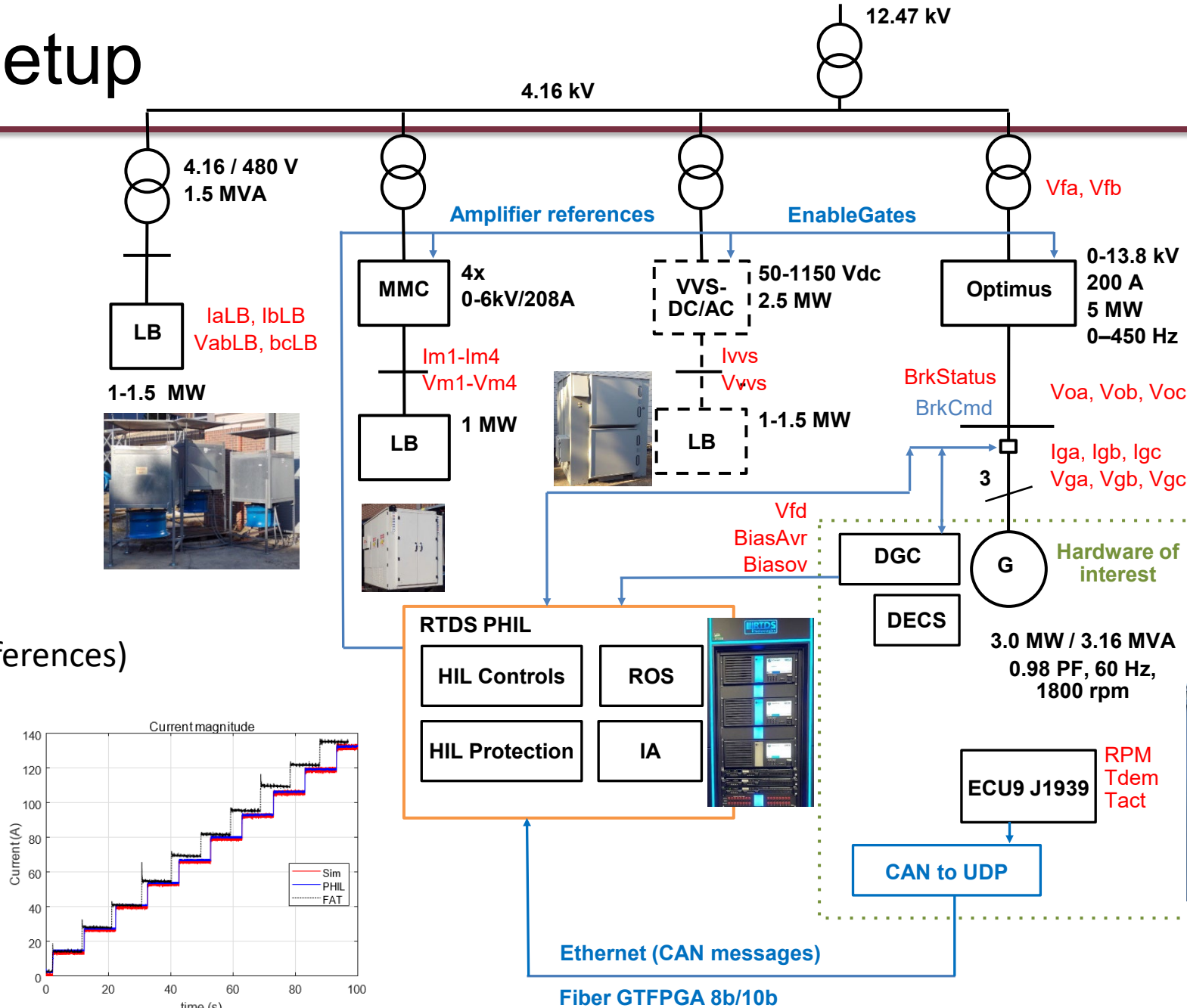
- Power amplifiers
- Load banks

Instrumentation

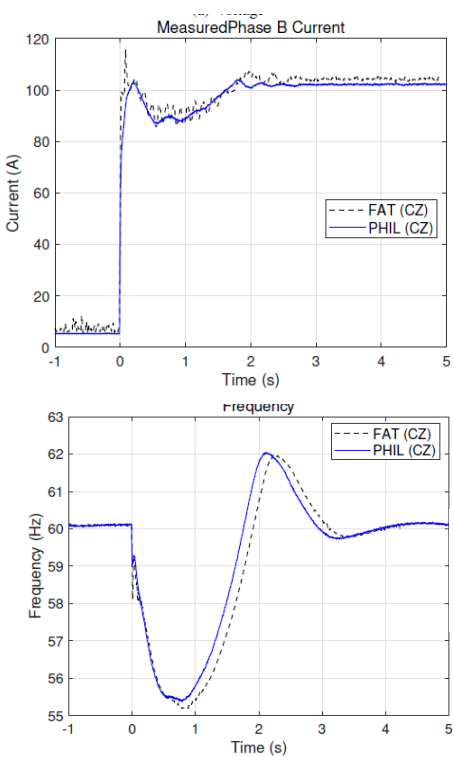
Signals to RTS (in red)

Communication (in blue)

- From RTS to amplifiers (references)
- CANbus



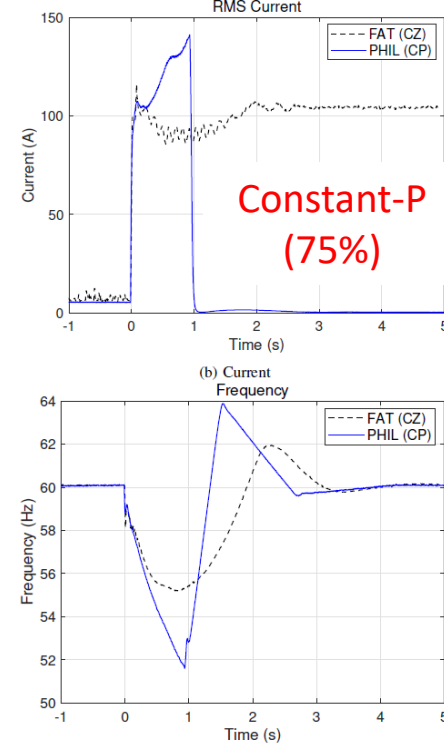
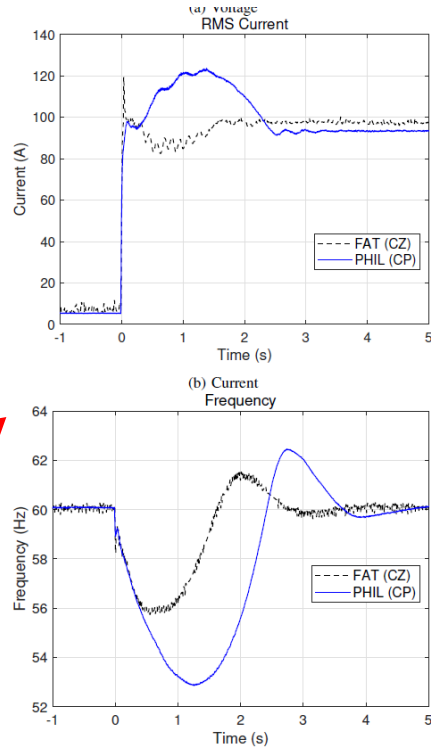
3 MW, 13.8 kV Diesel Generator Set



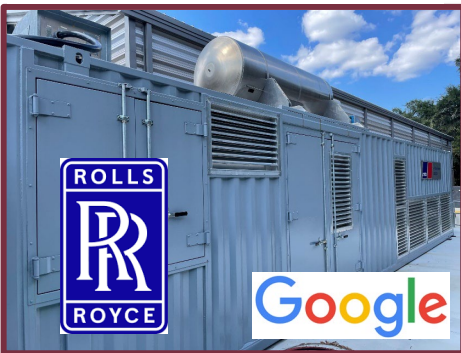
Constant-Z
(75%)



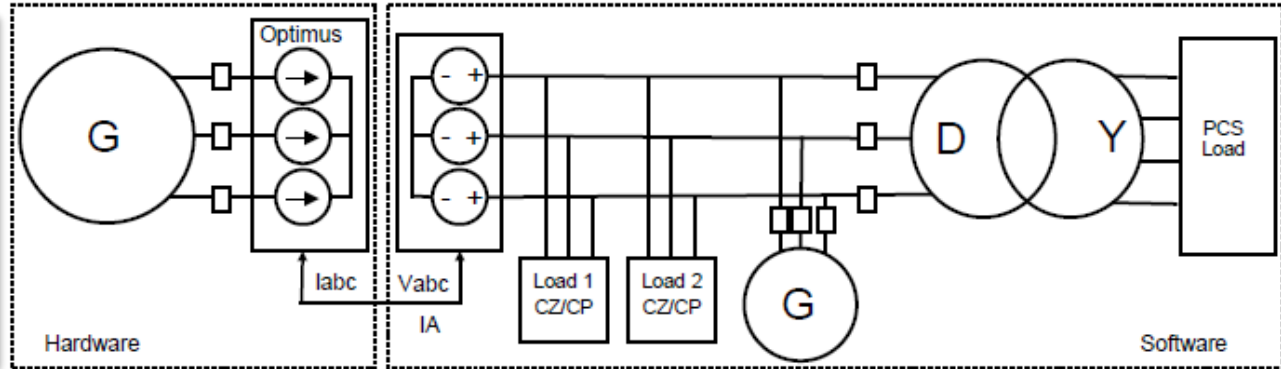
Constant-P
(70%)



Constant-P
(75%)



13.8 kV, 3 MW DG

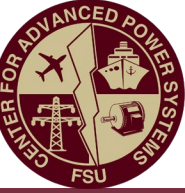


- Tested 3 MW, 13.8 kV DG
- PHIL Interface
 - DQ-frame DIM IA
 - Optimus amplifier configured for 13.8 kV AC, current control mode
- Studied response to dynamic changes in constant-power loads
 - Generator handled 100% constant-Z load step
 - Generator could only handle 70% constant-P load step
 - Experiment gracefully shut down without tripping the generator

Schoder, K., et al. "Dynamic Load Testing of a Diesel Generator Using Power Hardware-in-the-Loop Simulation." *2023 IEEE Electric Ship Technologies Symposium (ESTS)*. IEEE, 2023.



Virtual DIM

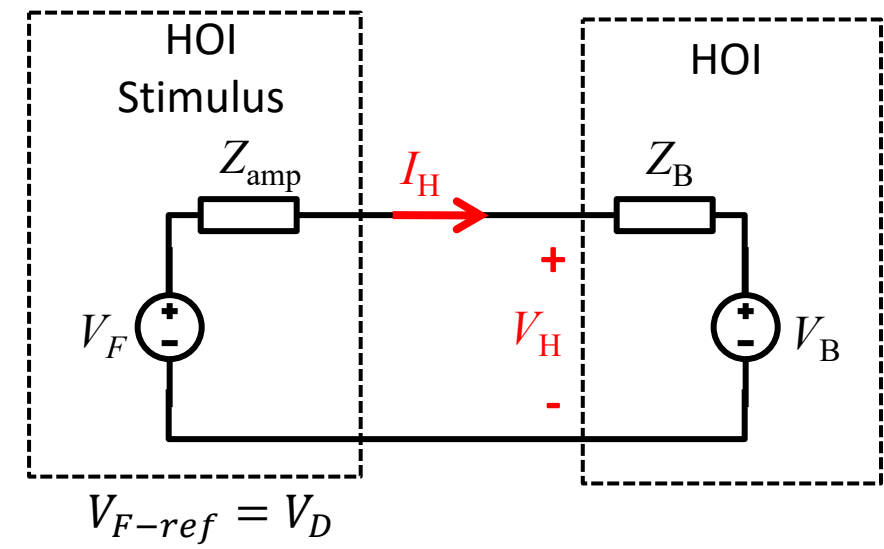
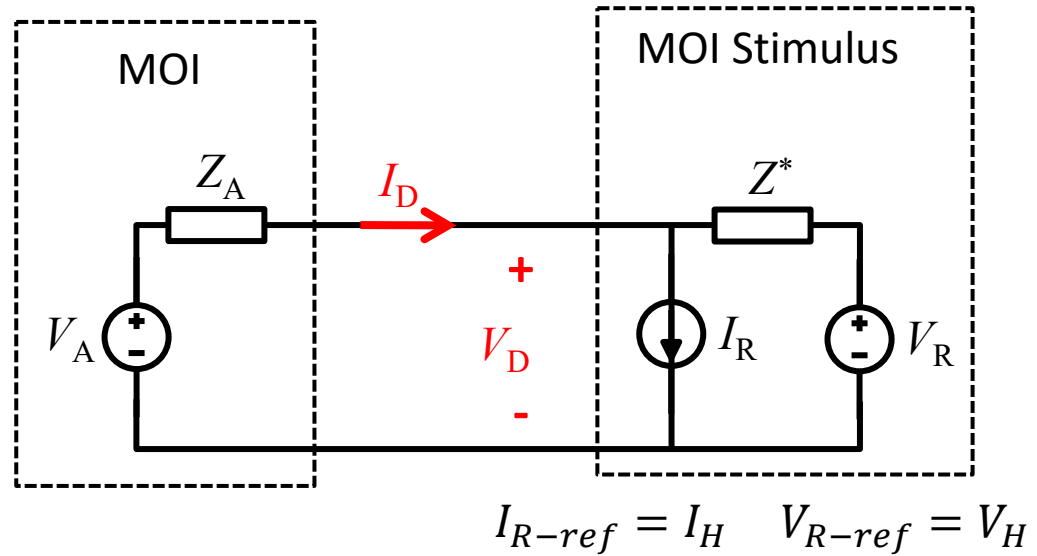


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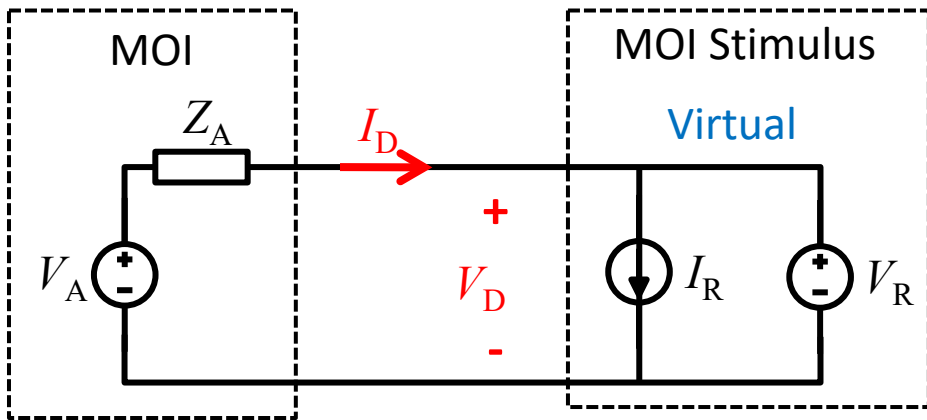
Damping Impedance Method

- Damping Impedance Method (DIM) interface approach (IA) commonly used in cases in which the ITM IA may not be stable
- If the damping impedance is closely matched to the HOI impedance
 - Guarantees stability
 - Generally shows high accuracy
- Potential issue with DIM IA if the HOI impedance is not easily represented by passive network (e.g. power converters in the low frequency range)
- Virtual DIM offers more flexibility – modeling arbitrary transfer function
 - Delays may affect representation of damping impedance at higher frequency
- Partial Virtual DIM combines flexibility of virtual DIM with better representation of damping impedance in the high frequency range

Will be presented at IECON'2024.

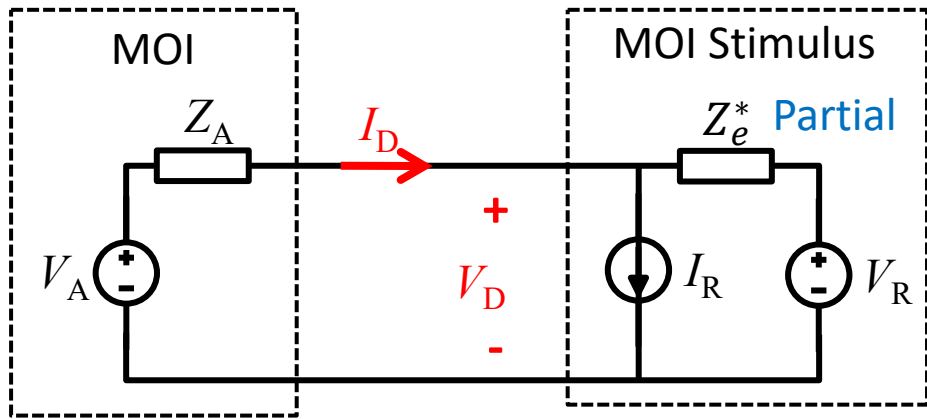


Virtual Damping Impedance Method



$$I_{R-ref} = I_H$$

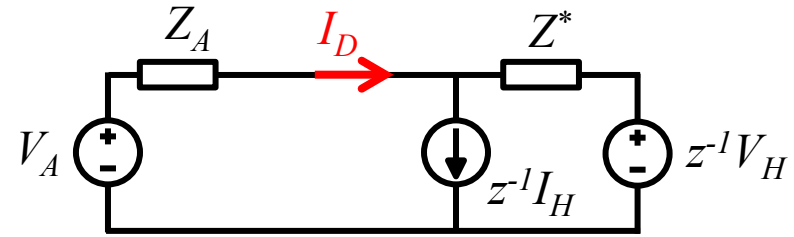
$$V_{R-ref} = V_H - (I_D - I_H)Z^*$$



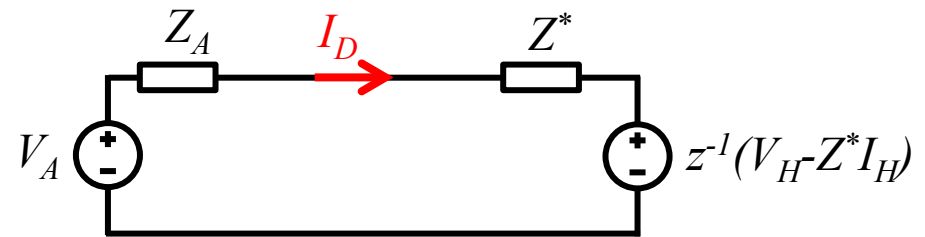
$$I_{R-ref} = I_H$$

$$V_{R-ref} = V_H - (I_D - I_H)Z_v^*$$

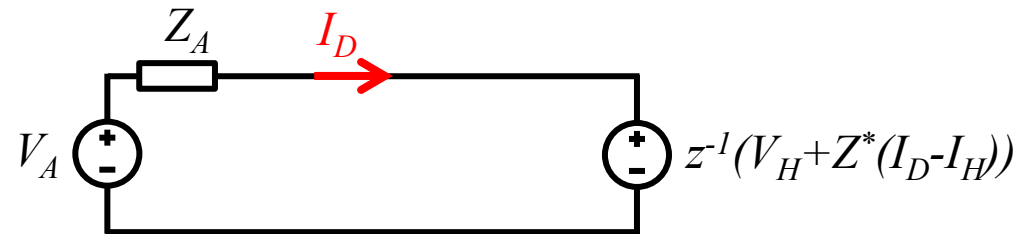
DIM with Explicit Damping Impedance (Normal)



DIM with Explicit Damping Impedance (Thevenin Equivalent)



DIM with Virtual Damping Impedance

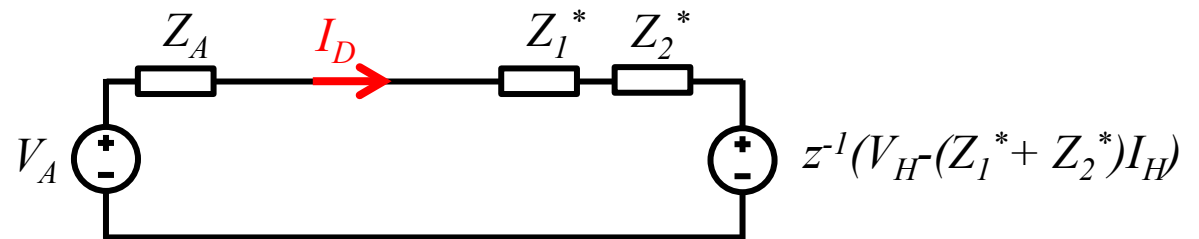
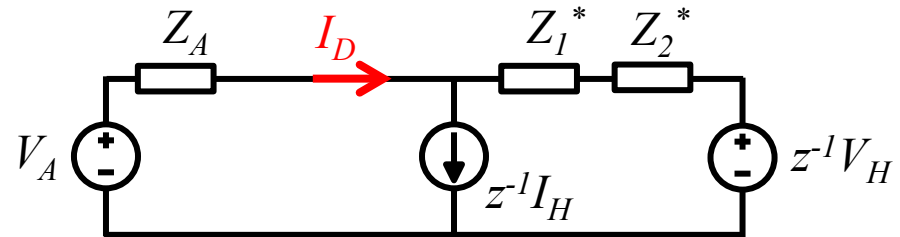


Consider Partial Virtual Impedance

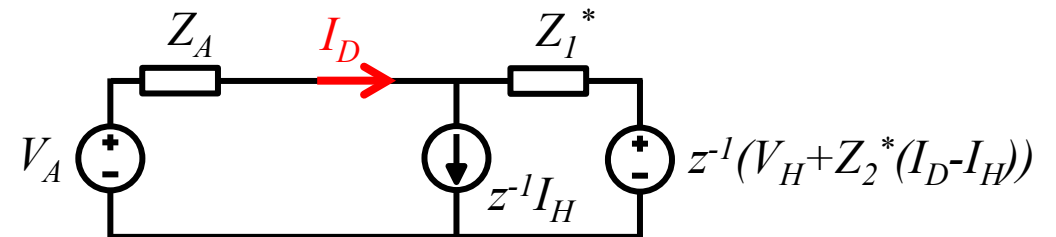
Application that benefits is to explicitly represent high frequency portion of impedance (which may well be represented by a passive network)

...along with a low-frequency MOI injection model, which may represent control behavior and not be well modeled by a passive network.

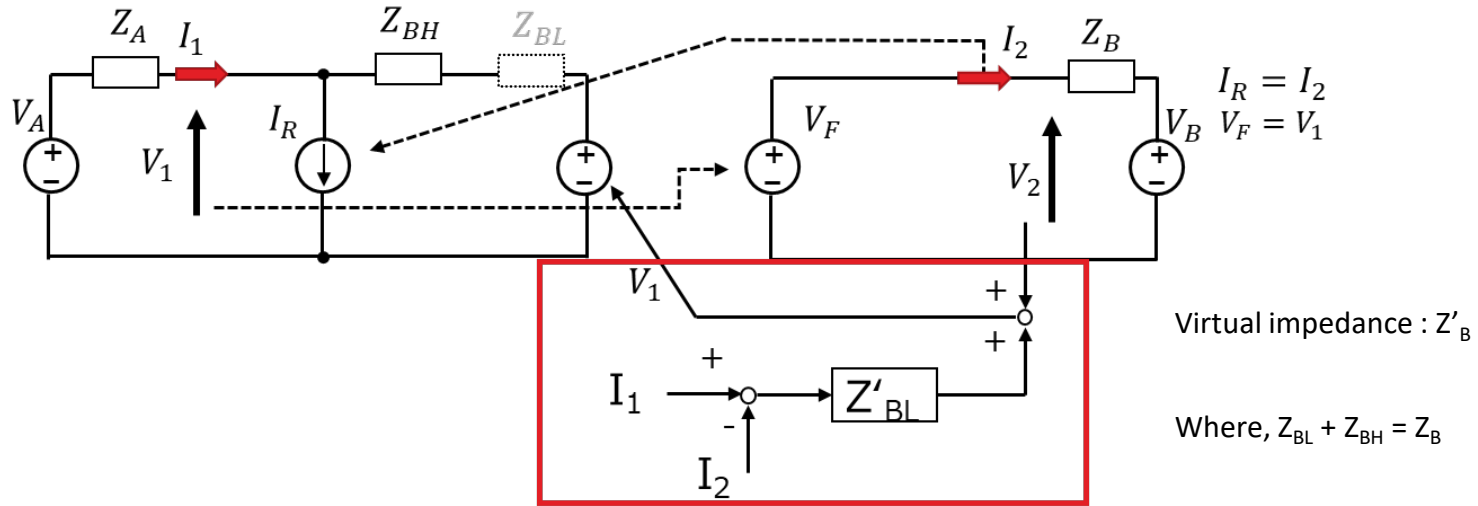
Partition Z^* into two components where, for example, Z_1^* captures high frequency behavior and Z_2^* captures low frequency behavior.

$$Z^* = Z_1^* + Z_2^*$$


DIM with Partial Virtual Damping Impedance



This method separates explicit impedance and ideal impedance.
It possess high stability and ease to introduce impedance characteristic.

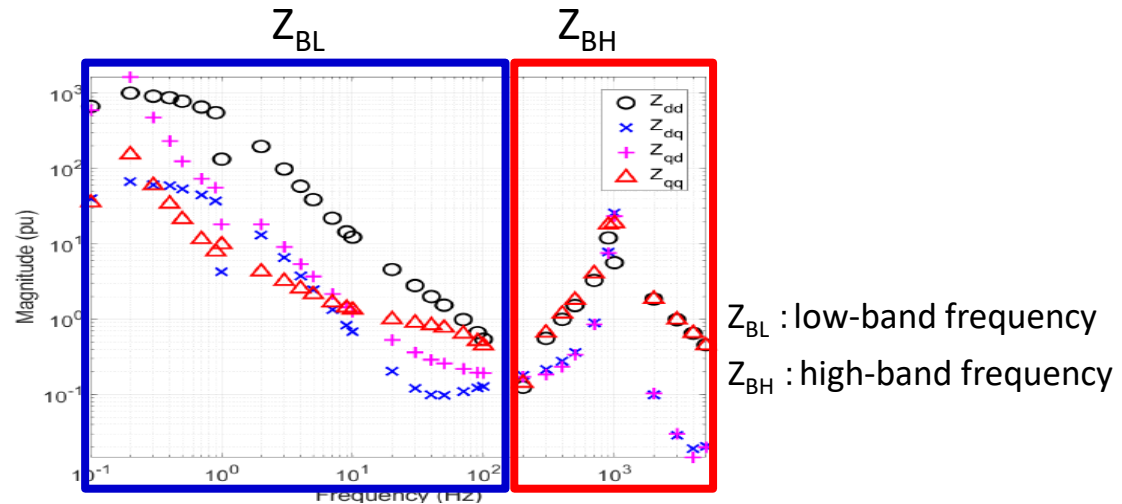


V-DIM open-loop gain

$$\frac{e^{-s2T_d} Z_B^*}{Z_A}$$

PV-DIM open-loop gain

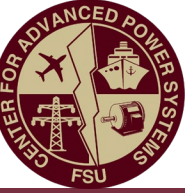
$$\frac{e^{-s2T_d} Z_{BL}^*}{(Z_A + Z_{BH})}$$



Z_{BL} : low-band frequency
 Z_{BH} : high-band frequency



Multi-Phase Linear Analysis



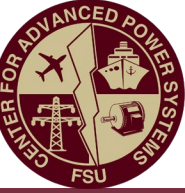
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Motivation



Generalized linear analysis of interface algorithms for multi-phase applications.

- Current practices
 - Custom analysis **specific** to the **case study** and **PHIL Interface Algorithm (IA)**
 - Conduct multi-phase PHIL **without proper assessment of stability, accuracy and sensitivity**
- Application and analysis of PHIL experiments utilizing **linear analysis framework** has been **conducted for single phase** interface system^[1] but **not for multi-phase systems**
- **Builds on Extended Lawrence Architecture (ELA) framework**
- Useful framework applicable to PHIL experiments independent of IA
 - **Successfully applied to a project**

Current Multi-Phase PHIL Analysis Methodology

- No common framework for analyzing different IA for a given PHIL experiment^[4]
- Hence deriving expressions and analyzing stability, accuracy and sensitivity **limited to specific experiment** being conducted

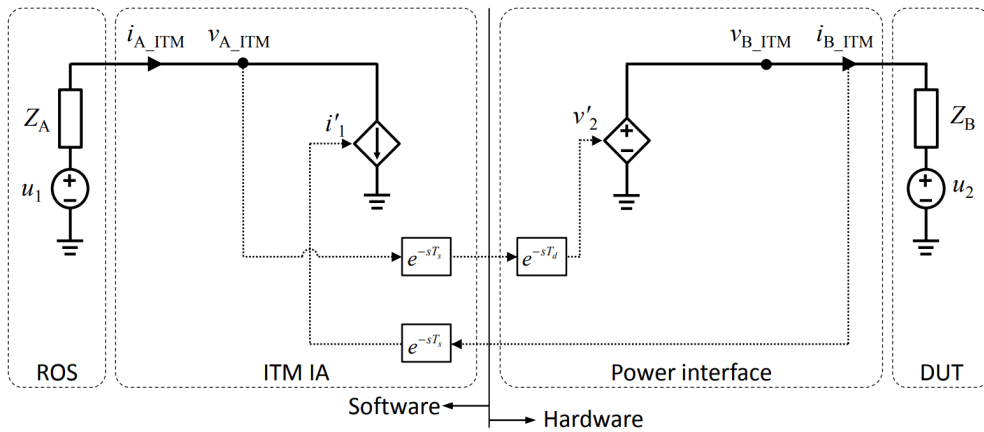


Fig. 3 PHIL system with ITM IA

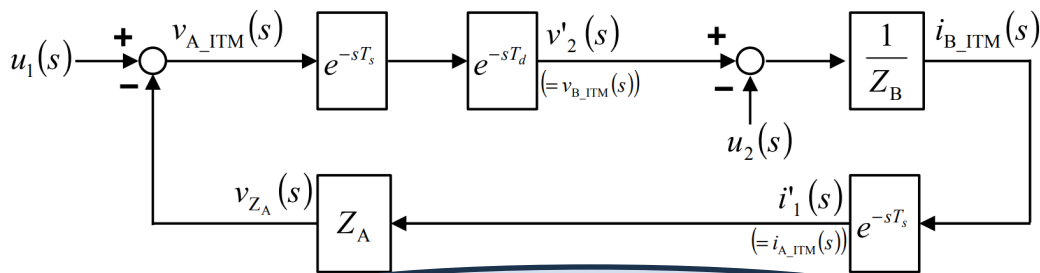


Fig. 4 Equivalent block diagram of the PHIL system with ITM IA

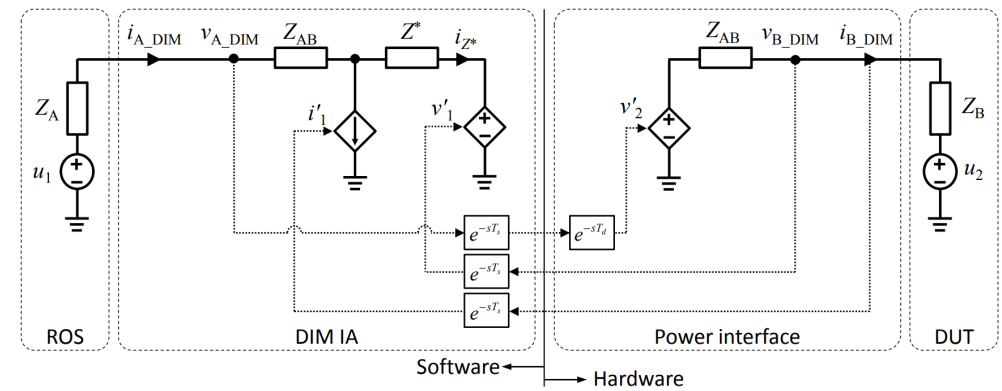


Fig. 5 PHIL system with DIM IA

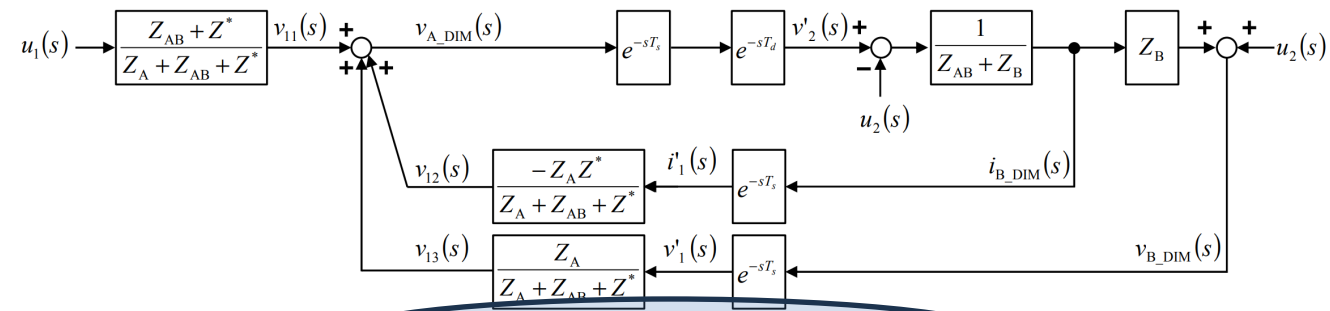
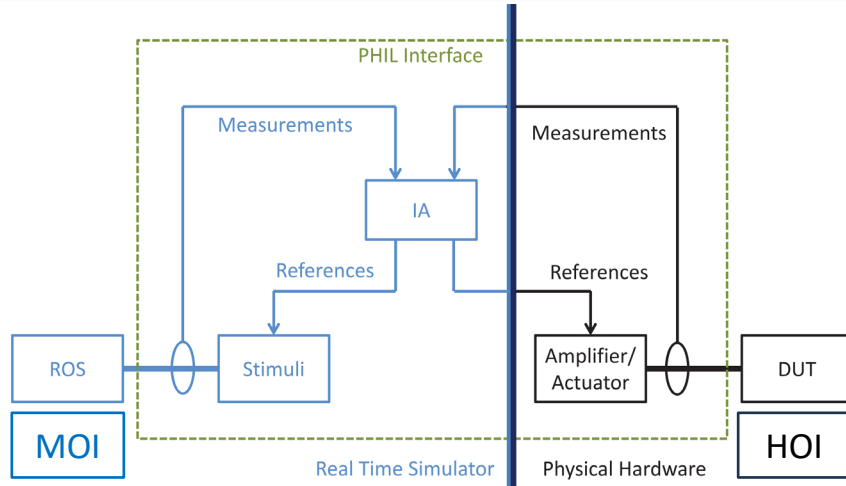
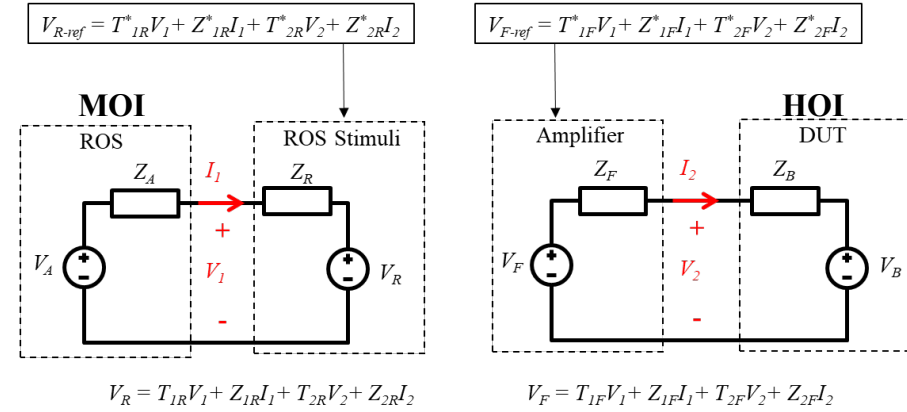


Fig. 6 Equivalent block diagram of the PHIL system with DIM IA

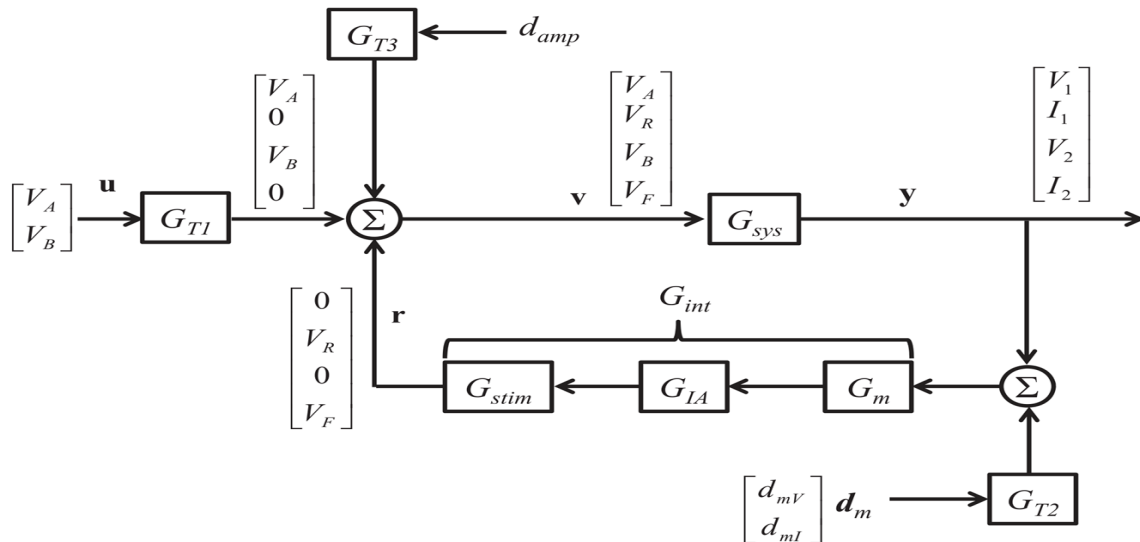
Linear Analysis Framework Using ELA for Single Phase PHIL System



Example PHIL Interface

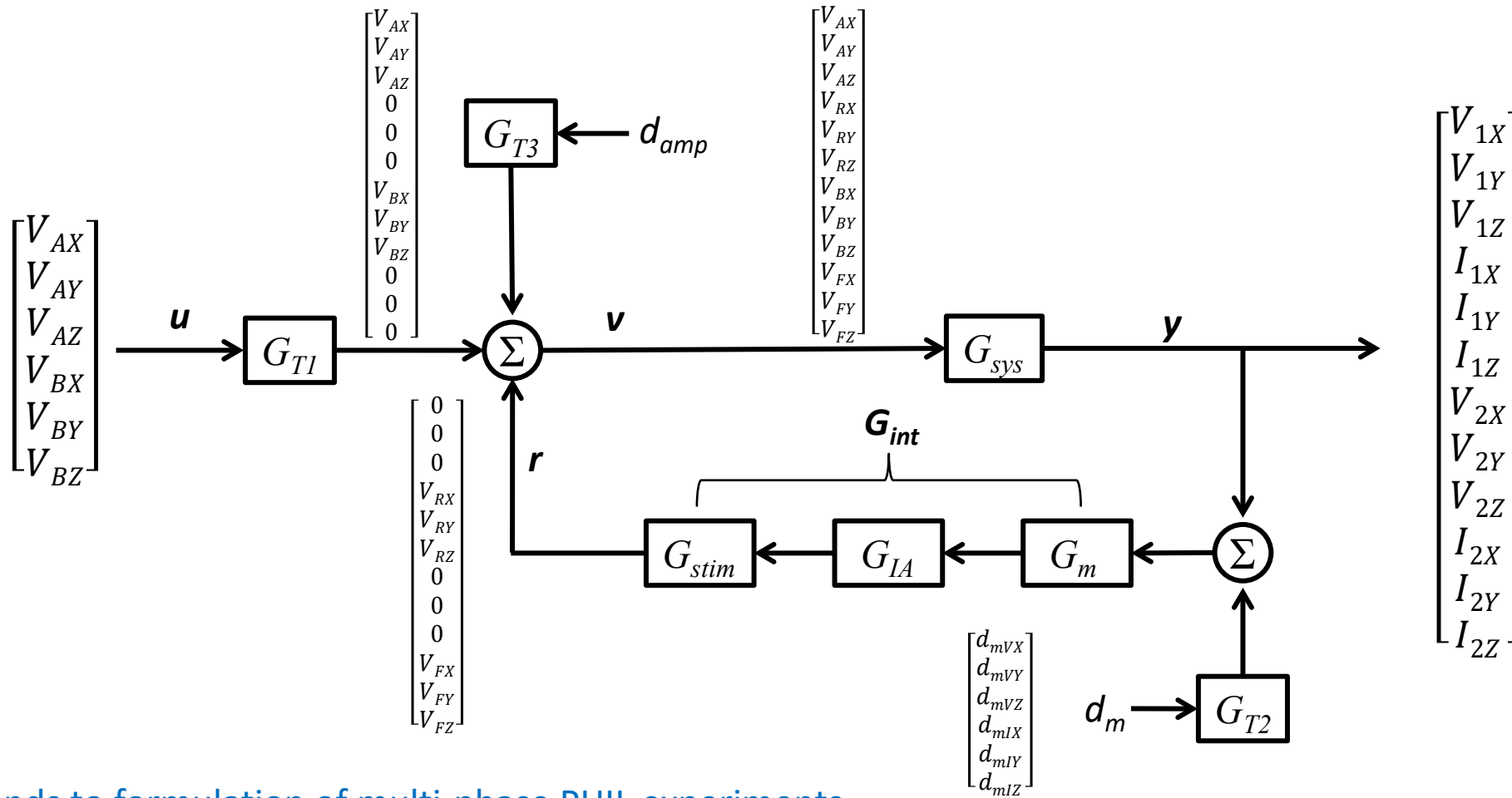


Example PHIL Simulation Employing IA of ELA^[5]



Compact formulation of PHIL experiment in terms of ELA^[5]

- G_{sys} – Mapping from inputs and stimuli to observable quantities
- G_{int} – Represents PHIL interface
- G_m – Effect of voltage and current sensors
- G_{IA} – IA gains
- G_{stim} – Effects of amplification and stimulation injections
- d_m – Noise at sensors measurements
- d_{amp} – Disturbance introduced through amplifier



ELA extends to formulation of multi-phase PHIL experiments.
 Unified structure for variations in phases.